

<b>Notice of References Cited</b>	Application/Control No. 10/636,144	Applicant(s)/Patent Under Reexamination COVERDILL ET AL.	
	Examiner Jungwon Chang	Art Unit 2154	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2002/0169861	11-2002	Chang et al.	709/223
*	B	US-7,124,173	10-2006	Moriarty, Kathleen M.	709/219
*	C	US-6,993,681	01-2006	Haynes et al.	714/23
*	D	US-6,976,071	12-2005	Donzis et al.	709/224
*	E	US-7,167,912	01-2007	Dhingra, Anurag	709/223
*	F	US-2004/0042438	03-2004	Jiang et al.	370/342
*	G	US-6,834,302	12-2004	Harvell, Joseph C.	709/224
*	H	US-2003/0158936	08-2003	Knop et al.	709/224
*	I	US-7,260,066	08-2007	Wang et al.	370/248
*	J	US-2002/0160812	10-2002	Moshiri-Tafreshi et al.	455/561
*	K	US-2003/0055882	03-2003	Kawamura, Nobuhiro	709/203
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.